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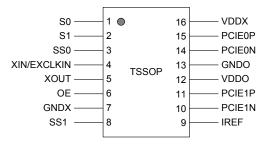
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### **Pinouts**

### Figure 1. 16-pin TSSOP pinout



# **Pin Definitions**

16-pin TSSOP

Pin Number	Pin Name	Pin Type	Description
1	S0	Input	Frequency select pin. Has internal weak pull-up. Refer to Output Frequency Selection Table on page 4.
2	S1	Input	Frequency select pin. Has internal weak pull-up. Refer to Output Frequency Selection Table on page 4.
3	SS0 <sup>[1]</sup>	Input	Spread spectrum select pin 0. Has internal weak pull-up. Refer to Spread Selection Table on page 4.
4	XIN/EXCLKIN	Input	Crystal or clock input. 25 MHz fundamental mode crystal or clock input.
5	XOUT	Output	Crystal output. 25 MHz fundamental mode crystal input. Float for clock input.
6	OE	Input	High true output enable pin. When set low, PCI-E outputs are tri-stated. Has internal weak pull-up.
7	GNDX	Power	Ground
8	SS1 <sup>[1]</sup>	Input	Spread spectrum select pin 1. has internal weak pull-up. Refer to Spread Selection Table on page 4.
9	IREF	Output	Current set for all differential clock drivers. Connect 475 $\Omega$ resistor to ground.
10	PCIE1N	Output	Differential PCI-Express complementary clock output. Tristated when disabled.
11	PCIE1P	Output	Differential PCI-Express true clock output. Tristated when disabled.
12	VDDO <sup>[2]</sup>	Input	3.3 V Power supply for output driver and analog circuits.
13	GNDO	Power	Ground
14	PCIE0N	Output	Differential PCI-Express complementary clock output. Tristated when disabled.
15	PCIE0P	Output	Differential PCI-Express true clock output. Tristated when disabled.
16	VDDX <sup>[2]</sup>	Input	3.3 V Power supply for oscillator and digital circuits.

#### Notes

Once powered up, state of SS1/SS0 pins should be held constant at the desired state.
 VDDX must be supplied faster or equal to VDDO.



# **Output Frequency Selection Table**

S1	S0	PCIE0[N,P], PCIE1[N,P]
0	0	25 MHz
0	1	100 MHz
1	0	125 MHz
1	1	200 MHz

# **Spread Selection Table**

SS1 <sup>[3]</sup>	SS0 <sup>[3]</sup>	Spread%
0	0	No Spread
0	1	-0.5%
1	0	-0.75%
1	1	No Spread



### **Application Information**

### **Crystal Recommendations**

CY24293 requires a parallel resonance crystal. Substituting a series resonance crystal causes the CY24293 to operate at the wrong frequency and violate the ppm specification. For most applications, there is a 300 ppm frequency shift between series and parallel crystals due to incorrect loading.

#### Table 1. Crystal Recommendations

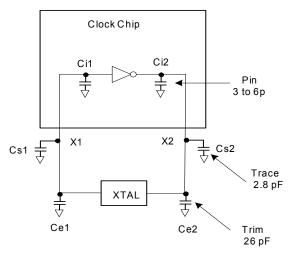
Frequency	Cut	Load Cap	Eff Series Rest (max)	Drive (max)	Tolerance (max)	Stability (max)	Aging (max)
25.00 MHz	Parallel	16 pF	<b>30</b> Ω	1.0 mW	30 ppm	10 ppm	5 ppm/yr.

### **Crystal Loading**

Crystal loading plays a critical role in achieving low ppm performance. To realize low ppm performance, consider the total capacitance the crystal sees to calculate the appropriate capacitive loading (CL).

Figure 2 shows a typical crystal configuration using two trim capacitors. It is important to note that the trim capacitors in series with the crystal are not parallel. It is a common misconception that load capacitors are in parallel with the crystal and must be approximately equal to the load capacitance of the crystal. This is not true.





#### **Calculating Load Capacitors**

In addition to the standard external trim capacitors, trace capacitance and pin capacitance must also be considered to correctly calculate crystal loading.

As mentioned in the previous section, the capacitance on each side of the crystal is in series with the crystal. This means the total capacitance on each side of the crystal must be twice the specified crystal load capacitance (CL). While the capacitance on each side of the crystal is in series with the crystal, trim capacitors (Ce1, Ce2) must be calculated to provide equal capacitive loading on both sides.

Use the following formulas to calculate the trim capacitor values for Ce1 and Ce2:

#### Load capacitance (each side)

$$\mathbf{Ce} = 2 * CL - (Cs + Ci)$$

#### Total capacitance (as seen by the crystal)

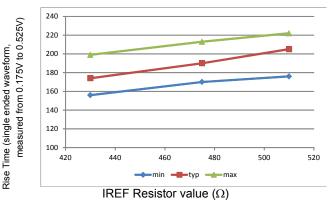
$$CLe = \frac{1}{\left(\frac{1}{Ce1 + Cs1 + Ci1} + \frac{1}{Ce2 + Cs2 + Ci2}\right)}$$

CL	Crystal load capacitance
CLe	Actual loading seen by crystal using standard value trim capacitors
Ce	External trim capacitors
Cs	Stray capacitance (terraced)
Ci	Internal capacitance

### Current Source (I<sub>REF</sub>) Reference Resistor

If the board target trace impedance (Z) is 50  $\Omega$ , then for  $R_{REF}$  = 475  $\Omega$  (1%), provides IREF of 2.32 mA. The output current (I<sub>OH</sub>) is equal to 6\*I<sub>REF</sub>. For other values of  $R_{REF}$ , the following graph can be referred. It demonstrates the relationship of variation of IREF w.r.t. rise time /fall time (TR/TF).

#### Figure 3. IREF vs. TR/TF relationship (Typical)





### **Output Termination**

The PCI-Express differential clock outputs of the CY24293 are open source drivers and require an external series resistor and a resistor to ground. These resistor values and their allowable locations are explained in Figure 4.

#### **PCB Layout Recommendations**

For optimum device performance and the lowest phase noise, the following guidelines must be observed:

- 1. Each 0.01  $\mu\text{F}$  decoupling capacitor must be mounted on the component side of the board as close to the  $V_{DD}$  pin as possible.
- 2. No vias must be used between the decoupling capacitor and the  $\mathsf{V}_{\mathsf{DD}}$  pin.

- 3. The PCB trace to the V<sub>DD</sub> pin and the ground via must be kept as short as possible. Distance of the ferrite bead and bulk decoupling from the device is less critical.
- 4. An optimum layout is one with all components on the same side of the board, minimizing vias through other signal layers (any ferrite beads and bulk decoupling capacitors can be mounted on the back). Other signal traces must be routed away from the CY24293. This includes signal traces just underneath the device, or on layers adjacent to the ground plane layer used by the device.

### **Decoupling Capacitors**

The decoupling capacitors of 0.01  $\mu$ F must be connected between V<sub>DD</sub> and GND as close to the device as possible. Do not share ground vias between components. Route power from the power source through the capacitor pad and then into the CY24293 pin.

# PCI-Express (HCSL Compatible) Layout Guidelines

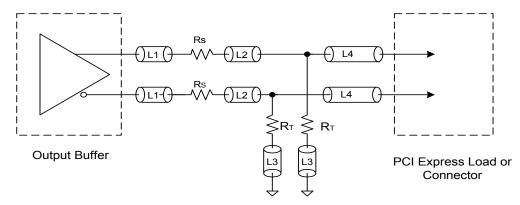
### Table 2. Common Recommendations for Differential Routing

Differential Routing	Dimension or Value	Unit
L1 length, route as non-coupled 50 $\Omega$ trace	0.5 max	inch
L2 length, route as non-coupled 50 $\Omega$ trace	0.2 max	inch
L3 length, route as non-coupled 50 $\Omega$ trace	0.2 max	inch
R <sub>S</sub>	33	Ω
R <sub>T</sub>	49.9	Ω

#### Table 3. Differential Routing for PCI-Express Load or Connector

Differential Routing	Dimension or Value	Unit
L4 length, route as coupled microstrip 100 $\Omega$ differential trace	2 to 32	inch
L4 length, route as coupled stripline 100 $\Omega$ differential trace	1.8 to 30	inch

### Figure 4. PCI-Express Differential Routing





# **Absolute Maximum Ratings**

Exceeding maximum ratings may shorten the useful life of the device. User guidelines are not tested.

Parameter	Description	Condition	Min	Max	Unit
V <sub>DD</sub>	Supply voltage		-0.5	4.6	V
V <sub>IN</sub>	Input voltage	Relative to V <sub>SS</sub>	-0.5	V <sub>DD</sub> + 0.5	V
Τ <sub>S</sub>	Temperature, Storage	Non Functional	-65	+150	°C
TJ	Temperature, Junction	Non Functional	-65	+150	°C
ESD <sub>HBM</sub>	ESD Protection (Human Body Model)	JEDEC EIA/JESD22-A114-E	2000	-	V
UL-94	Flammability rating	-	V-0 at 1/8 in.		
MSL	Moisture sensitivity level	-	3		

# **Recommended Operation Conditions**

Parameter	Description		Тур	Max	Unit
V <sub>DD</sub>	Supply voltage	3.0	-	3.6	V
T <sub>AC</sub>	Commercial ambient temperature	0	-	+70	°C
T <sub>AI/AA</sub>	Industrial ambient temperature	-40	-	+85	°C
t <sub>PU</sub>	Power up time for all $V_{DD}$ to reach minimum specified voltage (power ramps must be monotonic)	0.05	_	500	ms

### **DC Electrical Characteristics**

Unless otherwise stated, V<sub>DD</sub> = 3.3 V ± 0.3 V, ambient temperature = -40 °C to +85 °C Industrial, 0 °C to +70 °C Commercial

Parameter <sup>[4]</sup>	Description	Condition	Min	Тур	Max	Unit
V <sub>IL</sub>	Input low voltage	-	-0.3	-	0.8	V
V <sub>IH</sub>	Input high voltage	-	2.0	-	V <sub>DD</sub> + 0.3	V
V <sub>OL</sub>	Output low voltage of PCIE0[P/N], PCIE1[P/N]	HCSL termination ( $R_S = 33 \Omega$ , $R_T = 49.9 \Omega$ ). See note 19.	-0.2	0	0.05	V
V <sub>OH</sub>	Output high voltage of PCIE0[P/N], PCIE1[P/N]	HCSL termination ( $R_S = 33 \Omega$ , $R_T = 49.9 \Omega$ ). See note 19.	0.65	0.71	0.95	V
I <sub>DD</sub>	Operating supply current	No load, OE = 1	_	45	60	mA
I <sub>DDOD</sub>	Output disabled current	OE = 0	_	-	50	mA
C <sub>IN</sub>	Input capacitance	All input pins	_	5	-	pF
R <sub>PU</sub>	Pull-up resistance	S0, S1, SS0, SS1, OE	_	70k	_	Ω

### **Thermal Resistance**

Parameter <sup>[6]</sup>	Description	Test Conditions	16-pin TSSOP	Unit
$\theta_{JA}$		Test conditions follow standard test methods and procedures for measuring thermal impedance, in		°C/W
$\theta_{JC}$		accordance with EIA/JESD51.	12	°C/W

Note

Parameters are guaranteed by design and characterization. Not 100% tested in production.
 These parameters are guaranteed by design and are not tested.



# **AC Electrical Characteristics**

Unless otherwise stated: V<sub>DD</sub> = 3.3 V ± 0.3 V, ambient temperature = -40 °C to +85 °C Industrial, 0 °C to +70 °C Commercial, Outputs HCSL terminated.

Parameter <sup>[6]</sup>	Description	Condition	Min	Тур	Max	Unit
F <sub>IN</sub>	Input clock frequency (crystal or external clock)	-	-	25	-	MHz
T <sub>INDC</sub>	Input clock duty cycle	-	40	-	60	%
F <sub>OUT</sub>	Output frequency	HCSL termination	_	-	200	MHz
F <sub>ERR</sub>	Frequency synthesis error	-	_	0	-	ppm
T <sub>CCJ</sub>	Cycle-to-cycle jitter	See notes 7, 8	-	-	75	ps
SP <sub>PROFILE</sub>	Spread modulation profile	-	-	-	Lexmark	type
SP <sub>MOD</sub>	Spread modulation frequency	-	30	32	33	kHz
T <sub>DC</sub>	Output clock duty cycle	See notes: 7, 9	45	50	55	%
T <sub>OEH</sub>	Output enable time	OE going high to differential outputs becoming valid	-	-	200	ns
T <sub>OEL</sub>	Output disable time	OE going low to differential outputs becoming invalid	-	-	200	ns
T <sub>LOCK</sub>	Clock stabilization from power up	Measured from 90% of the applied power supply level	-	1	2	ms
T <sub>R</sub>	Output rise time	Measured from 0.175 V to 0.525 V. See notes: 7, 10	130	-	700	ps
T <sub>F</sub>	Output fall time	Measured from 0.525 V to 0.175 V. See notes: 7, 10	130	-	700	ps
DT <sub>R</sub>	Rise time variation	For a given frequency, Max $(T_R) - Min (T_R)$	-	-	125	ps
DT <sub>F</sub>	Fall time variation	For a given frequency, Max $(T_F)$ – Min $(T_F)$	-	-	125	ps
T <sub>OSKEW</sub>	Output skew	Measured at V <sub>CROSS</sub> point. See note: 11	-	-	50	ps
V <sub>CROSS</sub>	Absolute crossing point voltage	See notes: 9, 10, 12	0.25	0.35	0.55	V
V <sub>Xdelta</sub>	Variation of V <sub>CROSS</sub> over all rising clock edges	See notes: 9, 10, 13	_	_	140	mV

Notes

- 6. Parameters are guaranteed by design and characterization. Not 100% tested in production.
- Measured with Cload = 4 pF max. (scope probe + trace load).
   Measurement taken from differential waveform (PCIEP minus PCIEN). Either single ended probes with math or a differential probe can be used.
- 9. Measured at crossing point where the instantaneous voltage value of the rising edge of PCIEP equals the falling edge of PCIEN.
- 10. Measurement taken from single ended waveform.

12. Refers to the total variation from the lowest crossing point to the highest, regardless of which edge is crossing. Refers to all crossing points for this measurement. 13. Defined as the total variation of all crossing voltages of Rising PCIEP and Falling PCIEN. This is the maximum allowed variance in V<sub>CROSS</sub> for any particular system.

<sup>11.</sup> Measured at the rising 0V point of the differential signal. Skew is the time difference of the rising 0V point between any two differential signal pairs. The measurement is taken over 1000 samples, and the average value is used.



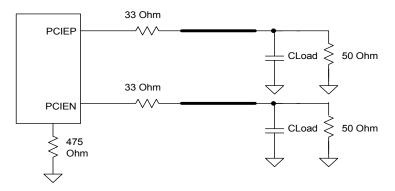
# AC Electrical Characteristics

Differential 100 MHz, HCSL Terminated Outputs (Parameters for the PCI Express Specification. Use above AC Characteristics parameter where it is not listed in this section)

Parameter	Description	Test Conditions	Min	Тур	Max	Units
F <sub>OUT</sub>	Output frequency		-	-	100	MHz
T <sub>PHJ</sub>	Peak-to-peak phase jitter	10 <sup>-6</sup> BER. Note: 14	-	30	86	ps
ER <sub>R</sub>	Rising edge rate	See notes: 15, 16	0.6	1.3	4.0	V/ns
ER <sub>F</sub>	Falling edge rate	See notes: 15, 16	0.6	1.3	4.0	V/ns
T <sub>PERIOD AVG</sub>	Average clock period accuracy	See notes: 15, 17	-300	-	2800	ppm
T <sub>PERIOD ABS</sub>	Absolute clock period	See notes: 15, 18	9.847	-	10.203	ns
RF <sub>MATCHING</sub>	Rising edge rate to falling edge rate matching	See note: 19, 20	_	_	20	%

### Test and Measurement Setup

### Figure 5. Test Load Configuration for Differential Output Signals



Notes

14. Phase jitter is determined using data captured on an oscilloscope at a sample rate of 20 GS/sec, for a minimum 100,000 continuous clock periods. This data is then processed using the ClockJitter 1.3.0 software from PCISIG, using the PCI\_E\_1\_1 template.
15. Measurement taken from differential waveform (PCIEP minus PCIEN). Either single ended probes with math or a differential probe can be used.
16. Measured from -150 mV on the differential waveform (derived from PCIEP minus PCIEN). The signal must be monotonic through the measurement region for rise and fall time. The 300 mV measurement window is centered on the differential zero crossing.

18. Defined as the absolute minimum or maximum instantaneous period. This includes cycle-to-cycle jitter, relative PPM tolerance, and spread spectrum modulation.

19. Measurement taken from single ended waveform.

<sup>17.</sup> PPM refers to parts per million and is a DC absolute period accuracy specification. The period is to be measured with a frequency counter with measurement window set to 100 ms or greater. The ±300 PPM applies to systems that do not employ Spread Spectrum or that use common clock source. For systems employing Spread Spectrum, there is an additional 2500 PPM nominal shift in maximum period resulting from the 0.5% down spread, resulting in a maximum average period specification of +2800 PPM.

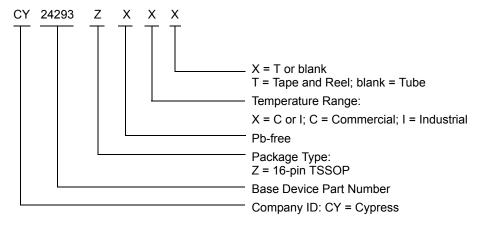
<sup>20.</sup> Matching applies to rising edge rate for PCIEP and falling edge for PCIEN. It is measured using a ± 75mV window centered on the median cross point where PCIEP rising meets PCIEN falling



# **Ordering Information**

Part Number	Туре	Production Flow
Pb-free		
CY24293ZXC	16-pin TSSOP	Commercial, 0 °C to 70 °C
CY24293ZXCT	16-pin TSSOP – Tape and Reel	Commercial, 0 °C to 70 °C
CY24293ZXI	16-pin TSSOP	Industrial, –40 °C to 85 °C
CY24293ZXIT	16-pin TSSOP – Tape and Reel	Industrial, –40 °C to 85 °C

### **Ordering Code Definitions**

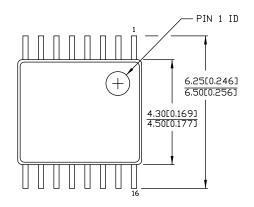






## Package Diagram

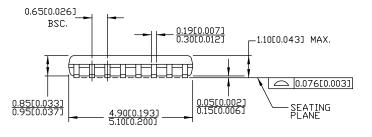
Figure 6. 16-pin TSSOP 4.40 mm Body Z16.173/ZZ16.173 Package Outline, 51-85091

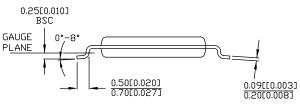


DIMENSIONS IN MMEINCHESJ MIN. MAX. REFERENCE JEDEC MO-153

PACKAGE WEIGHT 0.05gms

PART #					
Z16.173	STANDARD PKG.				
ZZ16.173	LEAD FREE PKG.				





51-85091 \*E



# Acronyms

Acronym	Description
EIA	electronic industries alliance
EMI	electromagnetic interference
ESD	electrostatic discharge
HCSL	high speed current steering logic
JEDEC	joint electron devices engineering council
PCB	printed circuit board
PCI	peripheral component interconnect
PLL	phase-locked loop
TSSOP	thin shrunk small outline package

# **Document Conventions**

### Units of Measure

Symbol	Unit of Measure			
°C	degree Celsius			
kHz	kilohertz			
MHz	megahertz			
μF	microfarad			
mA	milliampere			
ms	millisecond			
mV	millivolt			
mW	milliwatt			
ns	nanosecond			
Ω	ohm			
ppm	parts per million			
%	percent			
pF	picofarad			
ps	picosecond			
V	volt			



# **Document History Page**

Rev.	ECN No.	Orig. of Change	Submission Date	Description of Change
**	2490167	PYG/DPF/ AESA	See ECN	New data sheet.
*A	2507681	DPF / AESA	05/23/2008	Added Note 1: Parameters are guaranteed by design and characterization. N 100% tested in production. Added Note 2 for Duty cycle spec in the AC Elect. Characteristics. Added HCSL termination in Condition for $V_{OL}$ , $V_{OH}$ DC Elect. Char. Added V <sub>Xdelta</sub> value of 140 mV in the Differential 100 MHz HCSL output. Changed Cload from 2 pF to 4 pF in Note 2. Added internal weak Pull-ups for S0, S1, SS0, SS1 and OE pins. Updated T <sub>OEH</sub> and T <sub>OEL</sub> to 200 ns (max.). Updated to new template.
*B	2621901	CXQ / AESA	12/19/2008	Updated $I_{DD}$ spec in DC Electrical Characteristics. Added max spec for $I_{DDOD}$ DC Electrical Characteristics. Added $R_{PU}$ in DC Electrical Characteristics. Replaced $T_{RFVAR}$ with $DT_{R}$ and $DT_{F}$ in AC Electrical Characteristics. Added definitions for rise and fall time variation, crossing point variation in A Electrical Characteristics. Reduced cycle-to-cycle jitter spec to 75ps in AC Electrical Characteristics.
*C	2683343	CXQ / PYRA	04/03/2009	Changed status from Preliminary to Final. Added "max" to crystal ESR spec. Changed "LVDS Down Device" to "LVDS Device" in Table 8 and Figure 4.
*D	3289802	BASH	06/27/2011	Added Ordering Code Definitions. Updated Package Diagram. Added Acronyms and Units of Measure. Updated to new template.
*E	3395894	PURU	10/05/2011	Updated Features (Removed LVDS related information). Updated Functional Description (Removed LVDS related information). Updated Output Termination under Application Information (Removed LVD related information). Removed the section LVDS Compatible Layout Guidelines under the main section PCI-Express (HCSL Compatible) Layout Guidelines. Updated AC Electrical Characteristics (Removed LVDS related information Updated Package Diagram. Updated to new template.
*F	4467398	ХНТ	08/08/2014	Updated DC Electrical Characteristics: Changed maximum value of V <sub>OH</sub> parameter from 0.85 V to 0.95 V.
*G	4581659	TAVA	11/28/2014	Updated Functional Description: Added "For a complete list of related documentation, click here." at the end Updated Package Diagram.



# Document History Page (continued)

Rev.	ECN No.	Orig. of Change	Submission Date	Description of Change
*H	4817220	XHT	07/25/2015	Updated Pin Definitions: Added Note 1 and referred the same note in SS0 and SS1 pins. Added Note 2 and referred the same note in VDDO and VDDX pins. Updated Spread Selection Table: Added Note 3 and referred the same note in "SS1" and "SS0" columns. Updated Application Information: Updated Current Source (Iref) Reference Resistor: Updated description. Added Figure 3. Updated AC Electrical Characteristics: Added SP <sub>PROFILE</sub> parameter and its details. Added minimum value of SP <sub>MOD</sub> parameter (30 kHz). Added maximum value of SP <sub>MOD</sub> parameter (33 kHz). Updated Note 10 (Replaced differential with single ended). Added AC Electrical Characteristics (to specify PCIe parameter specifications Updated to new template. Completing Sunset Review.
*	5281627	PSR	05/23/2016	Added Thermal Resistance. Updated to new template.
*J	5787395	PSR	06/27/2017	Updated AC Electrical Characteristics: Added T <sub>INDC</sub> parameter. Updated template.



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